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TE	EST REPORT	
	For FCC Part15B	
Report No:	CHTEW22060010	Report verification:
Project No	SHT2205032403EW	
FCC ID:	2ASWWCORNP60	
Applicant's name:	XINCHUANGXIN INTERNATIO	NAL CO.,LTD
Address	ROOM 605 6/F, FA YUEN COM YUEN STREET MONGKOK KL	IMERCIAL BUILDING, 75-77 FA
Product Name:	Smart Phone	
Trade Mark	CORN	
Model No	P60	
Listed Model(s):		
Standard:	47 CFR FCC Part 15 Subpart B	3
Date of receipt of test sample:	May.20, 2022	
Date of testing	May.21, 2022-Jun.01, 2022	
Date of issue:	Jun.02, 2022	
Result:	Pass	
Compiled by		[alacizi
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Testing Laboratory Name: :	Testing Laboratory Name Shenzhen Huatongwei International Inspection Co., Ltd.	
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The test report merely corresponds to the test sample.

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1. TEST STANDARDS AND REPORT VERSION

1.1. Test Standards

The tests were performed according to following standards:

47 CFR FCC Part 15 Subpart B - Unintentional Radiators

ANSI C63.4: 2014 – American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40GHz

1.2. Report version information

Revision No.	Date of issue	Description
N/A	2022-06-02	Original

2. TEST DESCRIPTION

Section	tion Test Item Section in CFR 47		Result ^{#1}	Test Engineer	
5.1	Conducted Emissions	15.107(a)	PASS	Junman Wang	
5.2	Radiated Emissions	15.109(a)	PASS	Hongbin Zhong	

Note:

#1: The test result does not include measurement uncertainty value

3. <u>SUMMARY</u>

3.1. Client Information

Applicant:	XINCHUANGXIN INTERNATIONAL CO.,LTD	
Address:	ROOM 605 6/F, FA YUEN COMMERCIAL BUILDING, 75-77 FA YUEN STREET MONGKOK KL	
Manufacturer:	Shenzhen Chiteng Technology Co.,LTD	
Address:	Second Floor, Area A, Building 4, Huiye Technology Workshop, Guanguang Road, Tangjia Community, Gongming Street, Guangming New District, Shenzhen, Guangdong	

3.2. Product Description

Main unit information:		
Product Name:	Smart Phone	
Trade Mark:	CORN	
Model No.:	P60	
Listed Model(s):	-	
Power supply:	DC 3.8V from Battery	
Hardware version:	J527B-31EMB_D3_AF_V1.1	
Software version:	CORN_P60_S62301A01_V01_20220531	
Accessory unit information:		
	Model: CS001	
Adapter information:	Input: 100-240Va.c., 50/60Hz 0.15A	
	Output: 5Vd.c., 1A	

3.3. Testing Laboratory Information

Laboratory Name	Shenzhen Huatongwei International Inspection Co., Ltd.		
Laboratory Location	1/F, Bldg 3, Hongfa Hi-tech Industrial Park, Genyu Road, Tianliao, Gongming, Shenzhen, China		
	Tel: 86-755-26715499		
Connect information:	E-mail: <u>cs@szhtw.com.cn</u>		
	http://www.szhtw.com.cn		
Qualifications	Type Accreditation Numb		
Qualifications	FCC	762235	

4. TEST CONFIGURATION

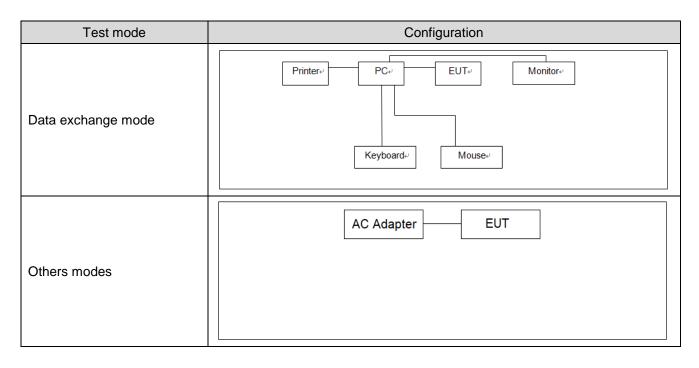
4.1. Descriptions of test mode

Test mode	Description
Camera recording mode	Keep the EUT in Camera recording status
Video Playing mode	Keep the EUT in Video Playing status
Data exchange mode	Keep the EUT in Data exchange with PC status

Pre-scan above all test mode, found below test mode which it was worse case mode, so only show the test data for worse case mode on the test report

Test Item	Test mode for worse case
Conducted Emissions	Video Playing mode
Radiated Emissions	Data exchange mode

4.2. Configuration of Tested System



4.3. Support unit used in test configuration and system

The EUT has been associated with peripherals and configuration operated in a manner tended to maximize its emission characteristics in a typical application.

Item	Equipment	Manufacturer	Model No.	FCC ID / FCC SDoC	Data Cable	Power Cord
1	PC	DELL	OptiPlex 3020 MT	FCC SDoC	N/A	Unshielded 1.8m
2	Monitor	DELL	E1912Hf	FCC SDoC	N/A	Unshielded 1.8m
3	Keyboard	DELL	SK8115	FCC SDoC	Unshielded, 1.5m	N/A
4	Mouse	DELL	MS111-T	FCC SDoC	Unshielded, 1.5m	N/A
5	Printer	EPSON	L101	FCC SDoC	N/A	Unshielded 1.8m

4.4. Environmental conditions

During the measurement the environmental conditions were within the listed ranges:

Temperature:	15~35°C
Relative Humidity:	30~60 %
Air Pressure:	950~1050mba

4.5. Statement of the measurement uncertainty

Test Items	MeasurementUncertainty
Conducted emission	3.25dB
Radiated emission	<1GHz: 4.22dB
	>1GHz:5.06ppm

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=1.96.

•	Conducted Emission						
Used	Test Equipment	Manufacturer	Equipment No.	Model No.	Serial No.	Last Cal. Date (YY-MM-DD)	Next Cal. Date (YY-MM-DD)
•	Shielded Room	Albatross projects	HTWE0114	N/A	N/A	2018/09/28	2023/09/27
•	EMI Test Receiver	R&S	HTWE0111	ESCI	101247	2021/9/14	2022/9/13
•	Artificial Mains	SCHWARZBECK	HTWE0113	NNLK 8121	573	2021/9/17	2022/9/16
•	Pulse Limiter	R&S	HTWE0033	ESH3-Z2	100499	2021/9/13	2022/9/12
•	RF Connection Cable	HUBER+SUHNER	HTWE0113-02	ENVIROFLE X_142	EF-NM- BNCM-2M	2021/9/17	2022/9/16
•	Test Software	R&S	N/A	ES-K1	N/A	N/A	N/A

4.6. Equipments Used during the Test

•	Radiated Emission-6th test site						
Used	Test Equipment	Manufacturer	Equipment No.	Model No.	Serial No.	Last Cal. Date (YY-MM-DD)	Next Cal. Date (YY-MM-DD)
•	Semi-Anechoic Chamber	Albatross projects	HTWE0127	SAC-3m-02	C11121	2018/09/30	2022/09/29
•	EMI Test Receiver	R&S	HTWE0099	ESCI	100900	2021/09/14	2022/09/13
•	Ultra-Broadband Antenna	SCHWARZBEC K	HTWE0119	VULB9163	546	2020/04/28	2023/04/27
•	Pre-Amplifer	SCHWARZBEC K	HTWE0295	BBV 9742	N/A	2021/11/05	2022/11/04
•	RF Connection Cable	HUBER+SUHN ER	HTWE0062-01	N/A	N/A	2022/02/25	2023/02/24
•	RF Connection Cable	HUBER+SUHN ER	HTWE0062-02	SUCOFLEX10 4	501184/4	2022/02/25	2023/02/24
•	Test Software	R&S	N/A	ES-K1	N/A	N/A	N/A

•	Radiated emission-7th test site						
Used	Test Equipment	Manufacturer	Equipment No.	Model No.	Serial No.	Last Cal. Date (YY-MM-DD)	Next Cal. Date (YY-MM-DD)
•	Semi-Anechoic Chamber	Albatross projects	HTWE0122	SAC-3m-01	C11121	2018/09/27	2022/09/26
•	Spectrum Analyzer	R&S	HTWE0098	FSP40	100597	2021/09/13	2022/09/12
•	Horn Antenna	SCHWARZBE CK	HTWE0126	9120D	1011	2020/04/01	2023/03/31
•	Broadband Pre- amplifier	SCHWARZBE CK	HTWE0201	BBV 9718	9718-248	2022/02/28	2023/02/27
•	RF Connection Cable	HUBER+SUH NER	HTWE0126-01	RE-7-FH	N/A	2022/03/04	2023/03/03
•	Test Software	Audix	N/A	E3	N/A	N/A	N/A

5. TEST CONDITIONS AND RESULTS

5.1. Conducted Emissions

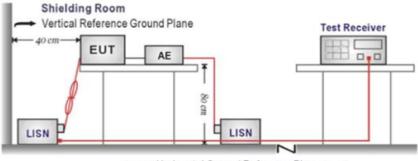
LIMIT

FCC CFR Title 47 Part 15 Subpart B Section 15.107:

Frequency range (MHz)	Limit (dBuV)		
Trequency range (MTZ)	Quasi-peak	Average	
0.15-0.5	66 to 56*	56 to 46*	
0.5-5	56	46	
5-30	60	50	

* Decreases with the logarithm of the frequency.

TEST CONFIGURATION



Horizontal Ground Reference Plane

TEST PROCEDURE

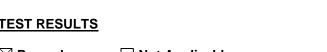
- The EUT was setup according to ANSI C63.4:2014 1.
- 2. The EUT was placed on a plat form of nominal size, 1 m by 1.5 m, raised 80 cm above the conducting ground plane. The vertical conducting plane was located 40 cm to the rear of the EUT. All other surfaces of EUT were at least 80 cm from any other grounded conducting surface.
- 3. The EUT and simulators are connected to the main power through a line impedance stabilization network (LISN). The LISN provides a 50ohm / 50uH coupling impedance for the measuring equipment.
- 4. The peripheral devices are also connected to the main power through a LISN. (Please refer to the block diagram of the test setup and photographs)
- 5. Each current-carrying conductor of the EUT power cord, except the ground (safety) conductor, was individually connected through a LISN to the input power source.
- The excess length of the power cord between the EUT and the LISN receptacle were folded back and 6. forth at the center of the lead to form a bundle not exceeding 40 cm in length.
- Conducted emissions were investigated over the frequency range from 0.15MHz to 30MHz using a receiver bandwidth of 9 kHz.
- 8. During the above scans, the emissions were maximized by cable manipulation.

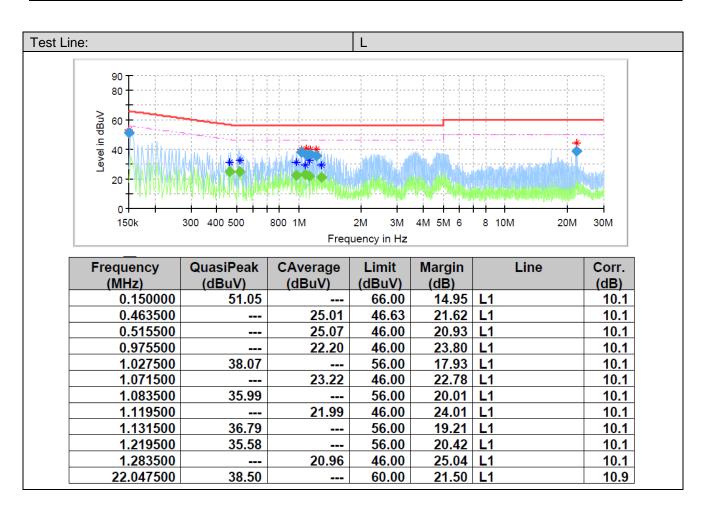
TEST MODE:

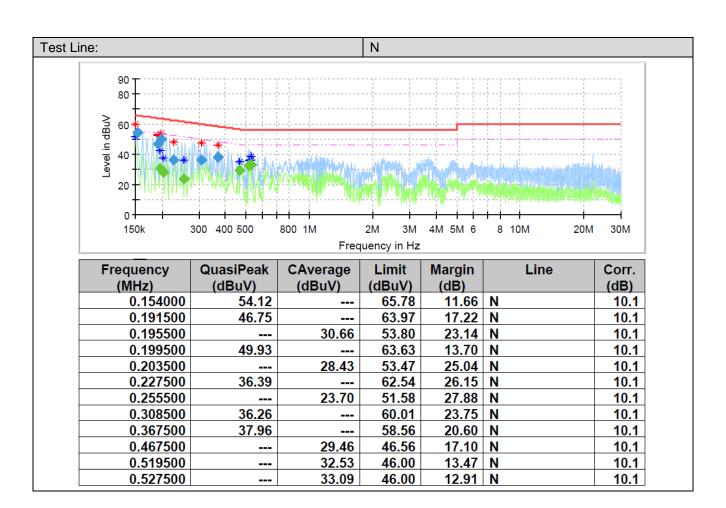
Please refer to the clause 3.3

TEST RESULTS

Passed Not Applicable







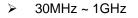
5.2. Radiated Emissions

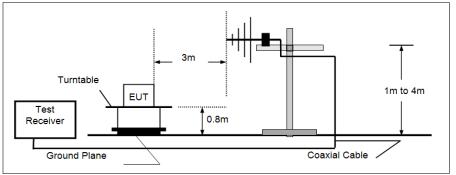
LIMIT

FCC CFR Title 47 Part 15 Subpart B Section 15.109

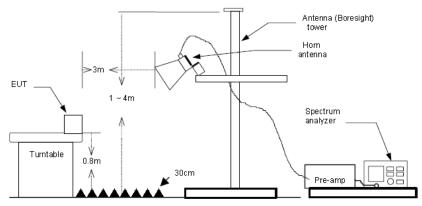
Frequency	Limit (dBuV/m @3m)	Value	
30MHz-88MHz	40.00	Quasi-peak	
88MHz-216MHz	43.50	Quasi-peak	
216MHz-960MHz	46.00	Quasi-peak	
960MHz-1GHz	54.00	Quasi-peak	
Above 1GHz	54.00	Average	
	74.00	Peak	

TEST CONFIGURATION





Above 1GHz



TEST PROCEDURE

- 1. The EUT was tested according to ANSI C63.4:2014.
- 2. The EUT is placed on a turn table which is 0.8 meter above ground.
- The turn table is rotated 360 degrees to determine the position of the maximum emission level. 3.
- 4. The EUT waspositioned such that the distance from antenna to the EUT was 3 meters.
- 5. The antenna is scanned from 1 meter to 4 meters to find out the maximum emission level. Thisis repeated for both horizontal and vertical polarization of the antenna.
- Use the following spectrum analyzer settings 6.
 - (1) Span shall wide enough to fully capture the emission being measured; (2) Below 1GHz,

RBW=120KHz, VBW=300KHz, Sweep=auto, Detector function=peak, Trace=max hold; If the emission level of the EUT measured by the peak detectoris 3 dB lower than the applicable limit, the peak emission level will be reported. Otherwise, the emission measurement will be repeated using the quasi-peak detector and reported.

(3) From 1GHz to 5th harmonic, RBW=1MHz, VBW=3MHz

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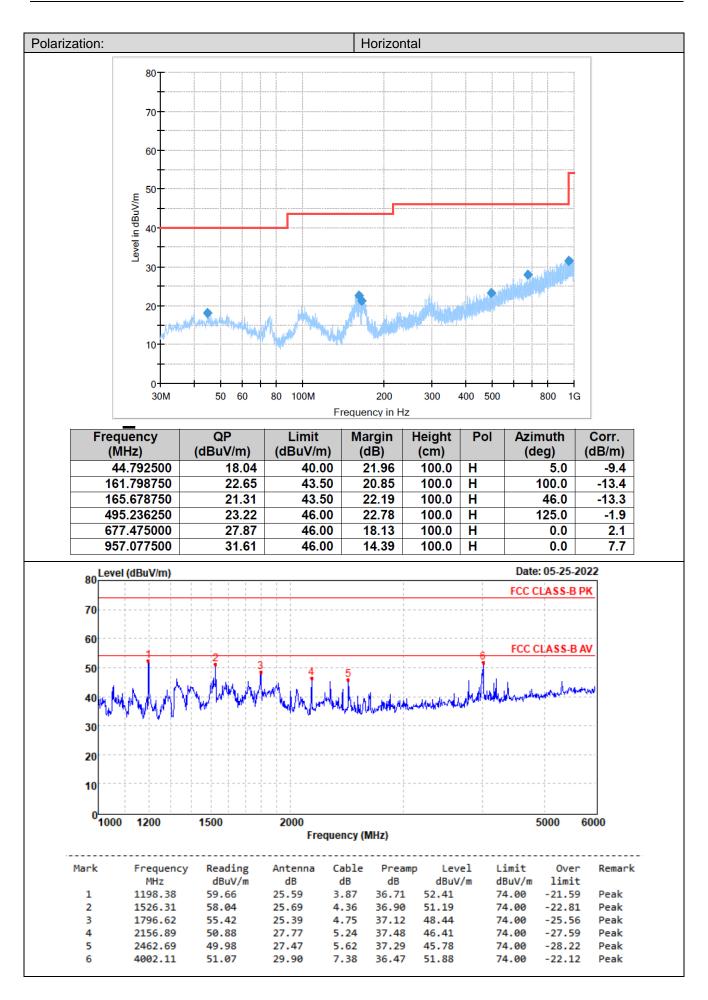
Please refer to the clause 3.3

TEST RESULTS

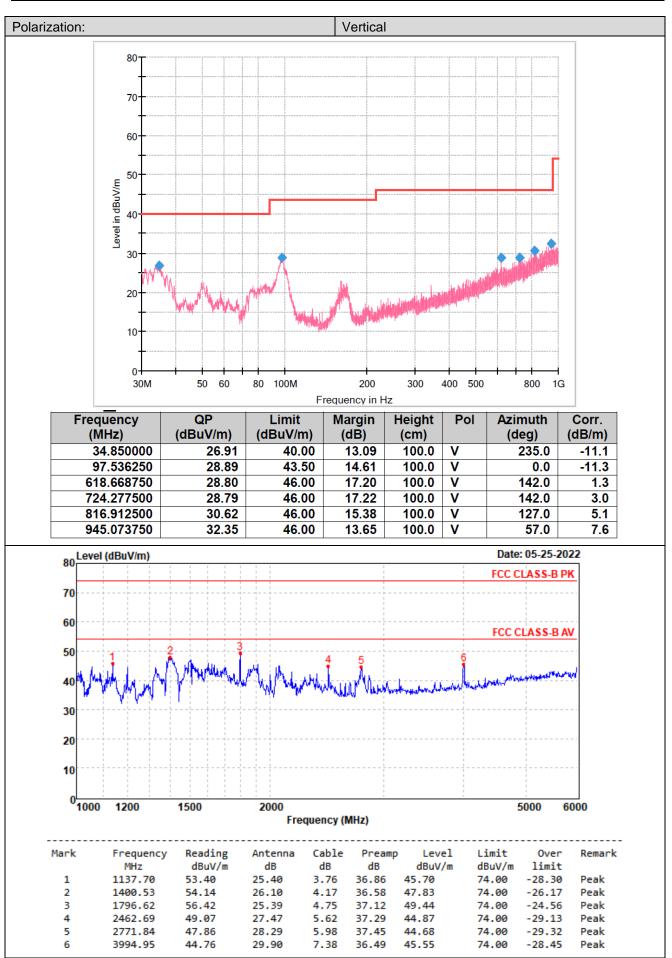
☑ Passed □ Not Applicable

Note: Final Level =Receiver Read level + Antenna Factor + Cable Loss – Preamplifier Factor The emission levels of frequency above 6GHz are very lower than limit and not show in test report.

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6. TEST SETUP PHOTOS

Conducted Emissions (AC Mains)



Radiated Emissions (30MHz-1GHz)



Radiated Emissions (Above 1GHz)



Page:

7. EXTERNAL AND INTERNAL PHOTOS

Refer to the test report No.: CHTEW22060005

-----End of Report------